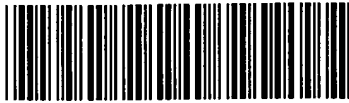


**Search Notes**

Application/Control No.

10/706,749

Examiner

Matthew G. Kayrish

Applicant(s)/Patent under  
Reexamination

FURUYA ET AL.

Art Unit

2627

**SEARCHED**

Class	Subclass	Date	Examiner
720	675	4/6/2006	MK

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR